


<b>Search Notes</b>  	<b>Application/Control No.</b>  10676067	<b>Applicant(s)/Patent Under Reexamination</b>  MATSUEDA ET AL.
	<b>Examiner</b>  Duong, Dieu Hien T	<b>Art Unit</b>  2821

SEARCHED			
Class	Subclass	Date	Examiner
315	169.2, 169.3	3/12/2008	dd

SEARCH NOTES		
Search Notes	Date	Examiner
Please See East Search History	3/12/2008	dd
Consulted with Thuy Tran, primary 315	3/12/2008	dd

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner